

# N-channel silicon field-effect transistors

## PMBFJ308; PMBFJ309; PMBFJ310

### FEATURES

- Low noise
- Interchangeability of drain and source connections
- High gain.

### APPLICATIONS

- AM input stage in car radios
- VHF amplifiers
- Oscillators and mixers.

### DESCRIPTION

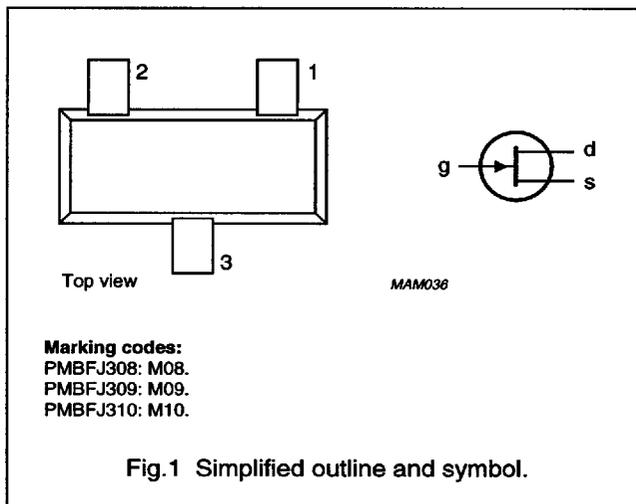
N-channel symmetrical silicon junction field-effect transistors in a SOT23 package.

### PINNING - SOT23

PIN	SYMBOL	DESCRIPTION
1	s	source
2	d	drain
3	g	gate

**CAUTION**

The device is supplied in an antistatic package. The gate-source input must be protected against static discharge during transport or handling.



### QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DS}$	drain-source voltage		-	$\pm 25$	V
$V_{GSoff}$	gate-source cut-off voltage	$V_{DS} = 10\text{ V}; I_D = 1\ \mu\text{A}$			
	PMBFJ308		-1	-6.5	V
	PMBFJ309		-1	-4	V
	PMBFJ310		-2	-6.5	V
$I_{DSS}$	drain current	$V_{GS} = 0; V_{DS} = 10\text{ V}$			
	PMBFJ308		12	60	mA
	PMBFJ309		12	30	mA
	PMBFJ310		24	60	mA
$P_{tot}$	total power dissipation	up to $T_{amb} = 25\text{ }^\circ\text{C}$	-	250	mW
$ y_{fs} $	forward transfer admittance	$V_{DS} = 10\text{ V}; I_D = 10\text{ mA}$	10	-	mS

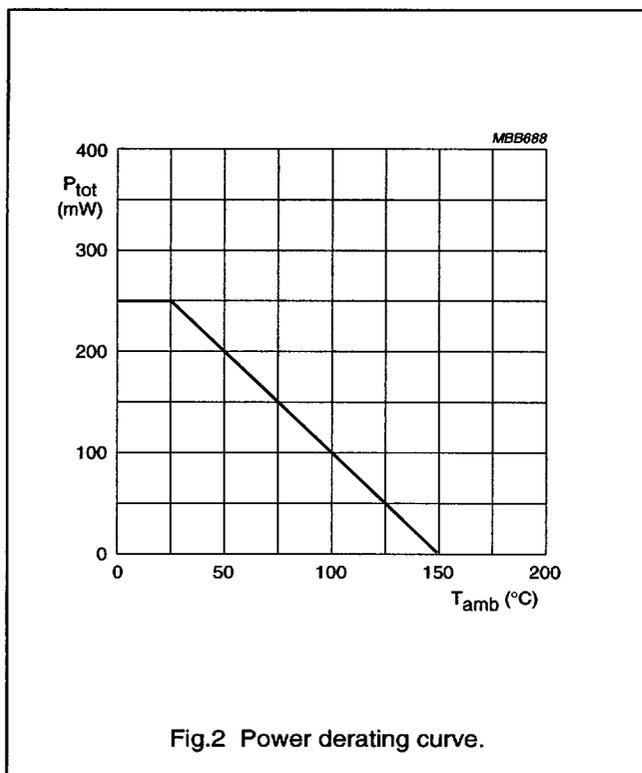
N-channel silicon field-effect transistors

PMBFJ308; PMBFJ309;  
PMBFJ310

**LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DS}$	drain-source voltage		–	±25	V
$V_{GSO}$	gate-source voltage	open drain	–	–25	V
$V_{GDO}$	gate-drain voltage	open source	–	–25	V
$I_G$	forward gate current (DC)		–	50	mA
$P_{tot}$	total power dissipation	up to $T_{amb} = 25\text{ °C}$	–	250	mW
$T_{stg}$	storage temperature		–65	150	°C
$T_j$	operating junction temperature		–	150	°C



## N-channel silicon field-effect transistors

PMBFJ308; PMBFJ309;  
PMBFJ310

## THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	VALUE	UNIT
$R_{th\ j-a}$	thermal resistance from junction to ambient; note 1	500	K/W

## Note

- Device mounted on an FR4 printed-circuit board.

## STATIC CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ ; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(BR)GSS}$	gate-source breakdown voltage	$I_G = -1\ \mu\text{A}$ ; $V_{DS} = 0$	-25	-	-	V
$V_{GSoff}$	gate-source cut-off voltage	$I_D = 1\ \mu\text{A}$ ; $V_{DS} = 10\ \text{V}$				V
	PMBFJ308		-1	-	-6.5	V
	PMBFJ309		-1	-	-4	V
	PMBFJ310		-2	-	-6.5	V
$V_{GSS}$	gate-source forward voltage	$I_G = 1\ \text{mA}$ ; $V_{DS} = 0$	-	-	1	V
$I_{DSS}$	drain current	$V_{DS} = 10\ \text{V}$ ; $V_{GS} = 0$				mA
	PMBFJ308		12	-	60	mA
	PMBFJ309		12	-	30	mA
	PMBFJ310		24	-	60	mA
$I_{GSS}$	gate leakage current	$V_{GS} = -15\ \text{V}$ ; $V_{DS} = 0$	-	-	-1	nA
$R_{DSon}$	drain-source on-state resistance	$V_{GS} = 0$ ; $V_{DS} = 100\ \text{mV}$	-	50	-	$\Omega$
$ y_{fs} $	forward transfer admittance	$I_D = 10\ \text{mA}$ ; $V_{DS} = 10\ \text{V}$	10	-	-	mS
$ y_{os} $	common source output admittance	$I_D = 10\ \text{mA}$ ; $V_{DS} = 10\ \text{V}$	-	-	250	$\mu\text{S}$

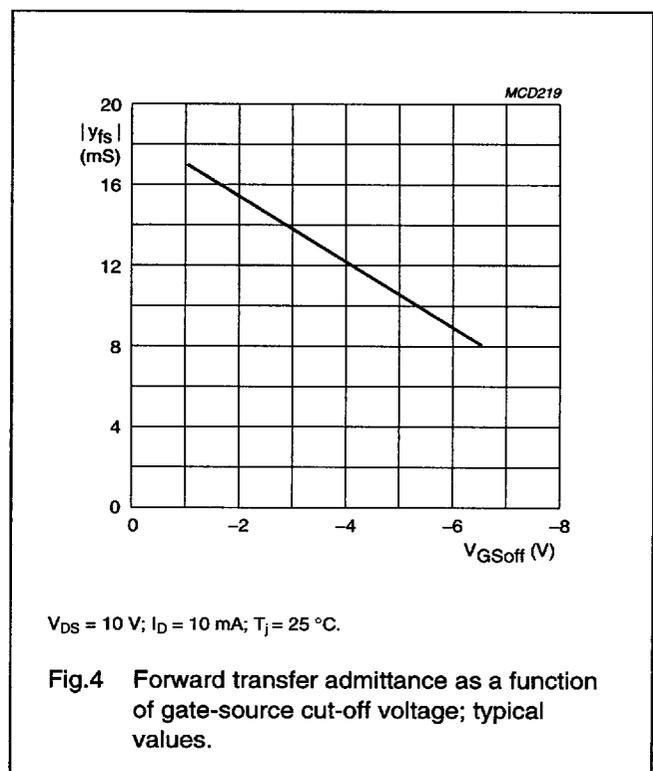
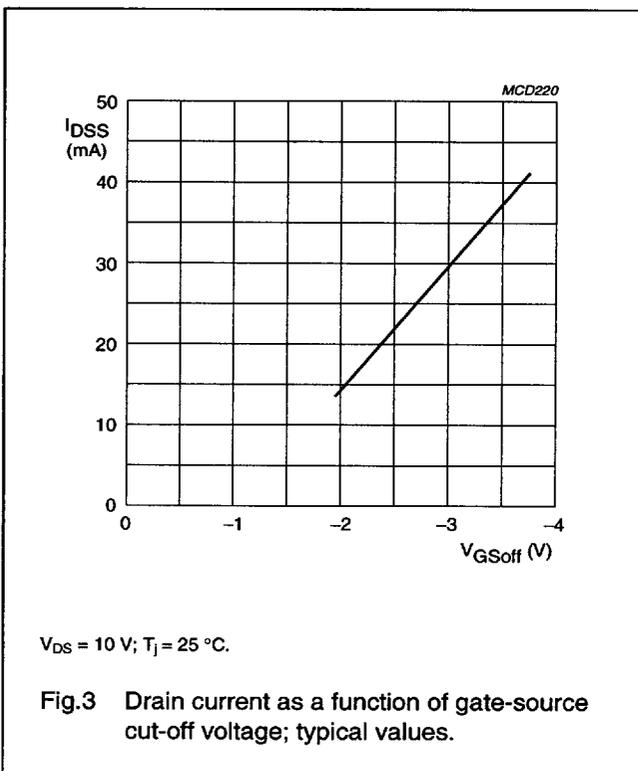
N-channel silicon field-effect transistors

PMBFJ308; PMBFJ309;  
PMBFJ310

**DYNAMIC CHARACTERISTICS**

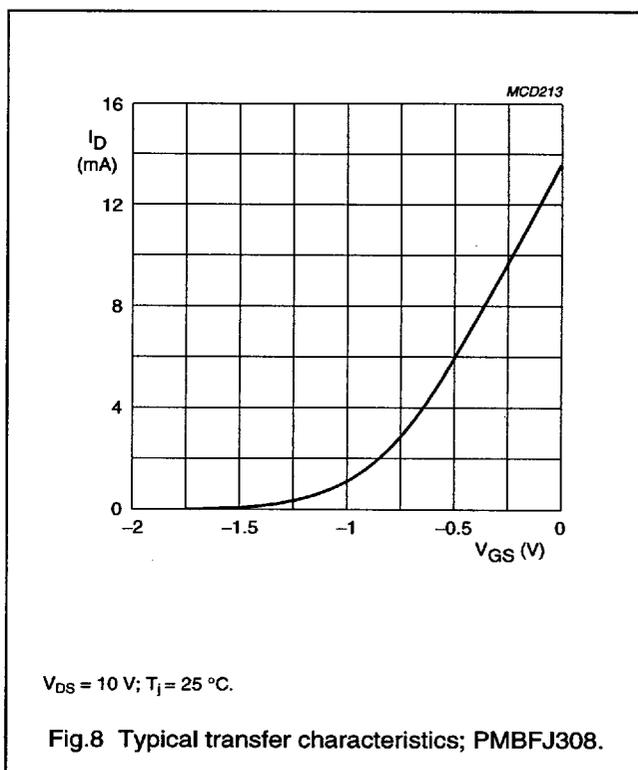
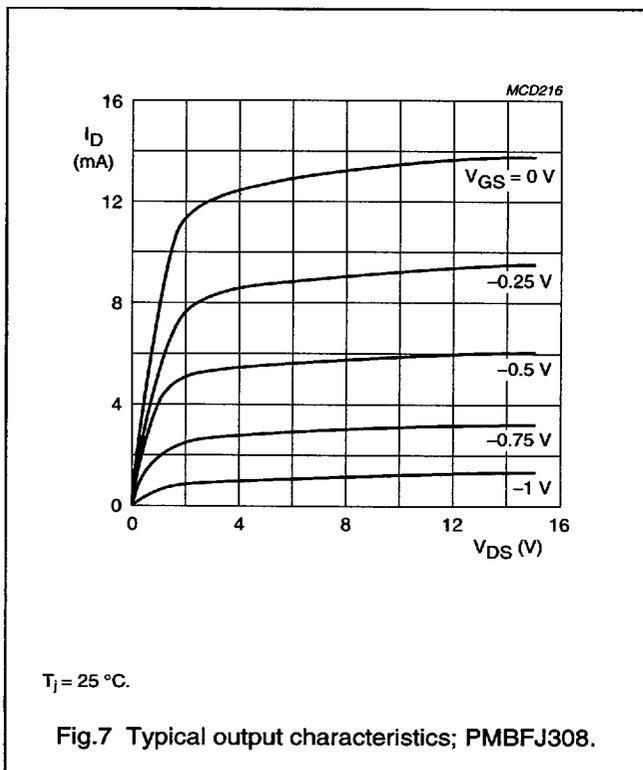
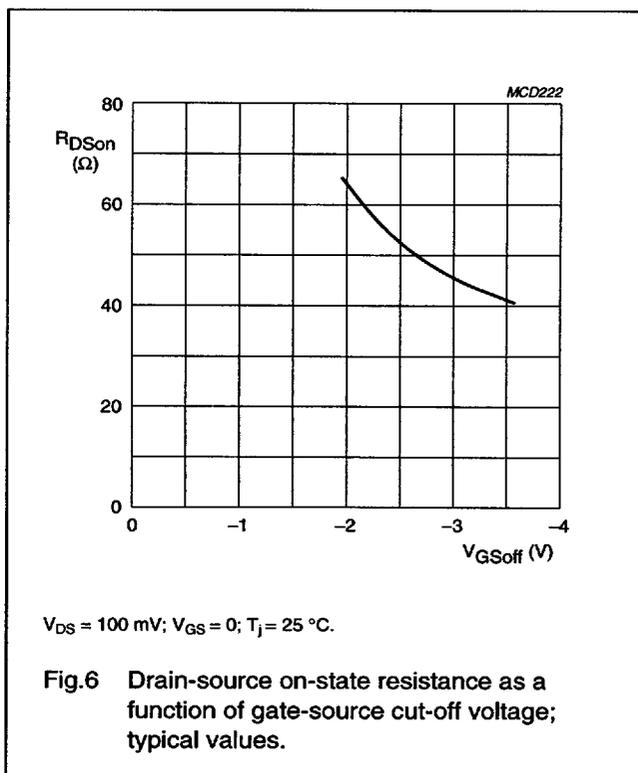
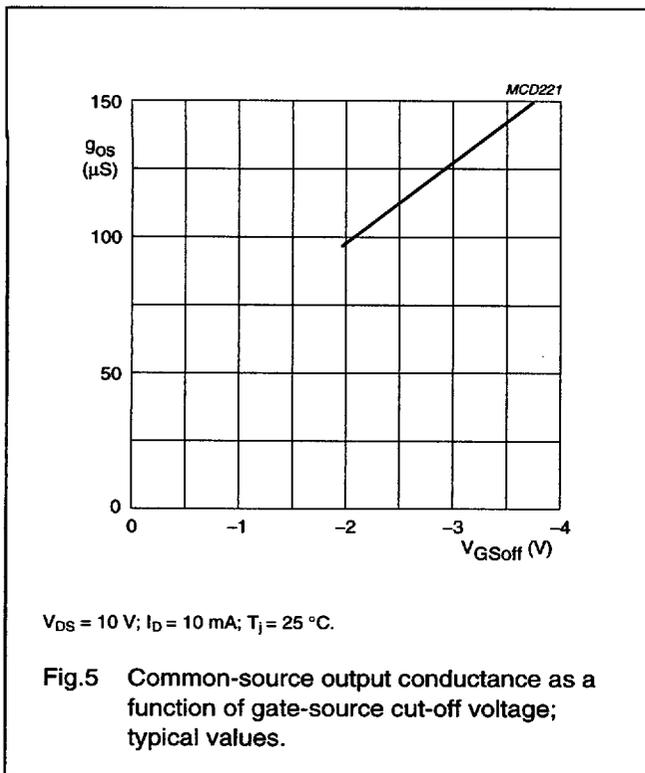
$T_j = 25\text{ }^\circ\text{C}$ ; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
$C_{is}$	input capacitance	$V_{DS} = 10\text{ V}; V_{GS} = -10\text{ V}; f = 1\text{ MHz}$	3	5	pF
		$V_{DS} = 10\text{ V}; V_{GS} = 0; T_{amb} = 25\text{ }^\circ\text{C}$	6	–	pF
$C_{rs}$	reverse transfer capacitance	$V_{DS} = 0; V_{GS} = -10\text{ V}; f = 1\text{ MHz}$	1.3	2.5	pF
$g_{is}$	common source input conductance	$V_{DS} = 10\text{ V}; I_D = 10\text{ mA}; f = 100\text{ MHz}$	200	–	$\mu\text{S}$
		$V_{DS} = 10\text{ V}; I_D = 10\text{ mA}; f = 450\text{ MHz}$	3	–	mS
$g_{fs}$	common source transfer conductance	$V_{DS} = 10\text{ V}; I_D = 10\text{ mA}; f = 100\text{ MHz}$	13	–	mS
		$V_{DS} = 10\text{ V}; I_D = 10\text{ mA}; f = 450\text{ MHz}$	12	–	mS
$g_{rs}$	common source reverse conductance	$V_{DS} = 10\text{ V}; I_D = 10\text{ mA}; f = 100\text{ MHz}$	–30	–	$\mu\text{S}$
		$V_{DS} = 10\text{ V}; I_D = 10\text{ mA}; f = 450\text{ MHz}$	–450	–	$\mu\text{S}$
$g_{os}$	common source output conductance	$V_{DS} = 10\text{ V}; I_D = 10\text{ mA}; f = 100\text{ MHz}$	150	–	$\mu\text{S}$
		$V_{DS} = 10\text{ V}; I_D = 10\text{ mA}; f = 450\text{ MHz}$	400	–	$\mu\text{S}$
$V_n$	equivalent input noise voltage	$V_{DS} = 10\text{ V}; I_D = 10\text{ mA}; f = 100\text{ Hz}$	6	–	nV/ $\sqrt{\text{Hz}}$



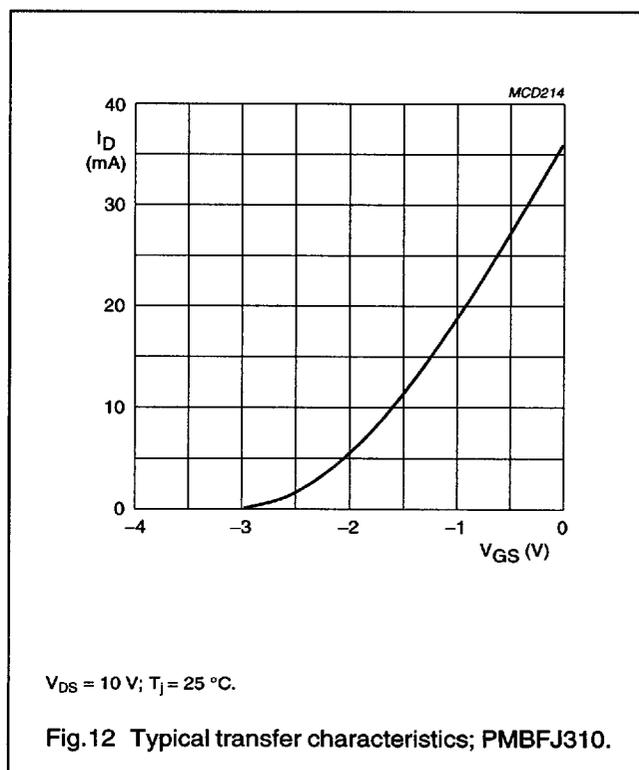
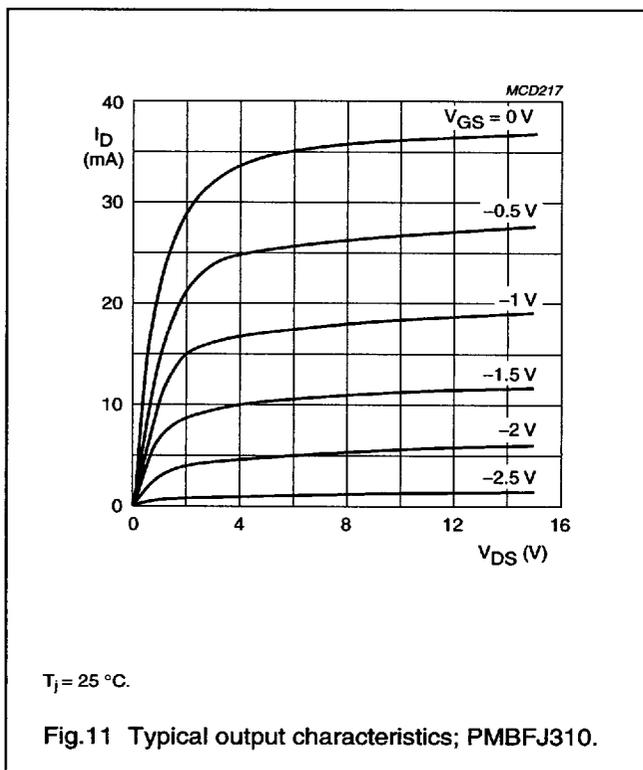
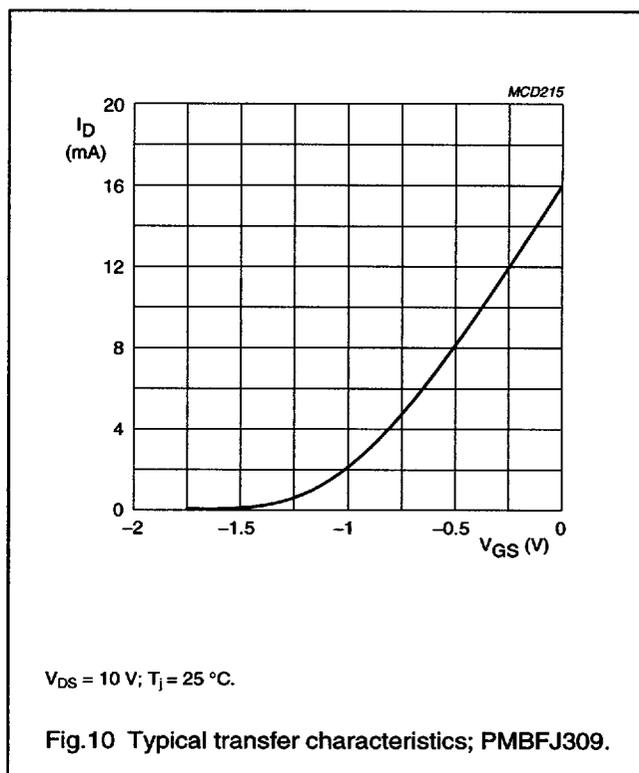
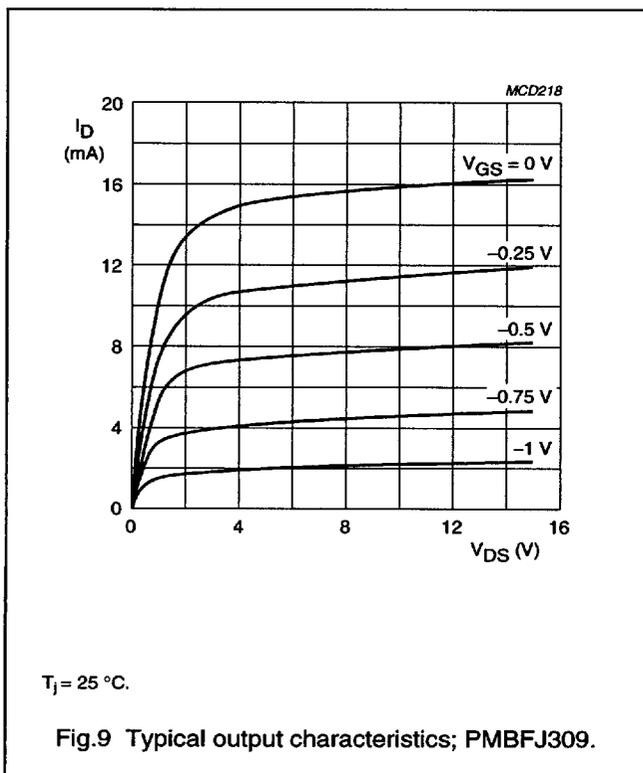
N-channel silicon field-effect transistors

PMBFJ308; PMBFJ309;  
PMBFJ310



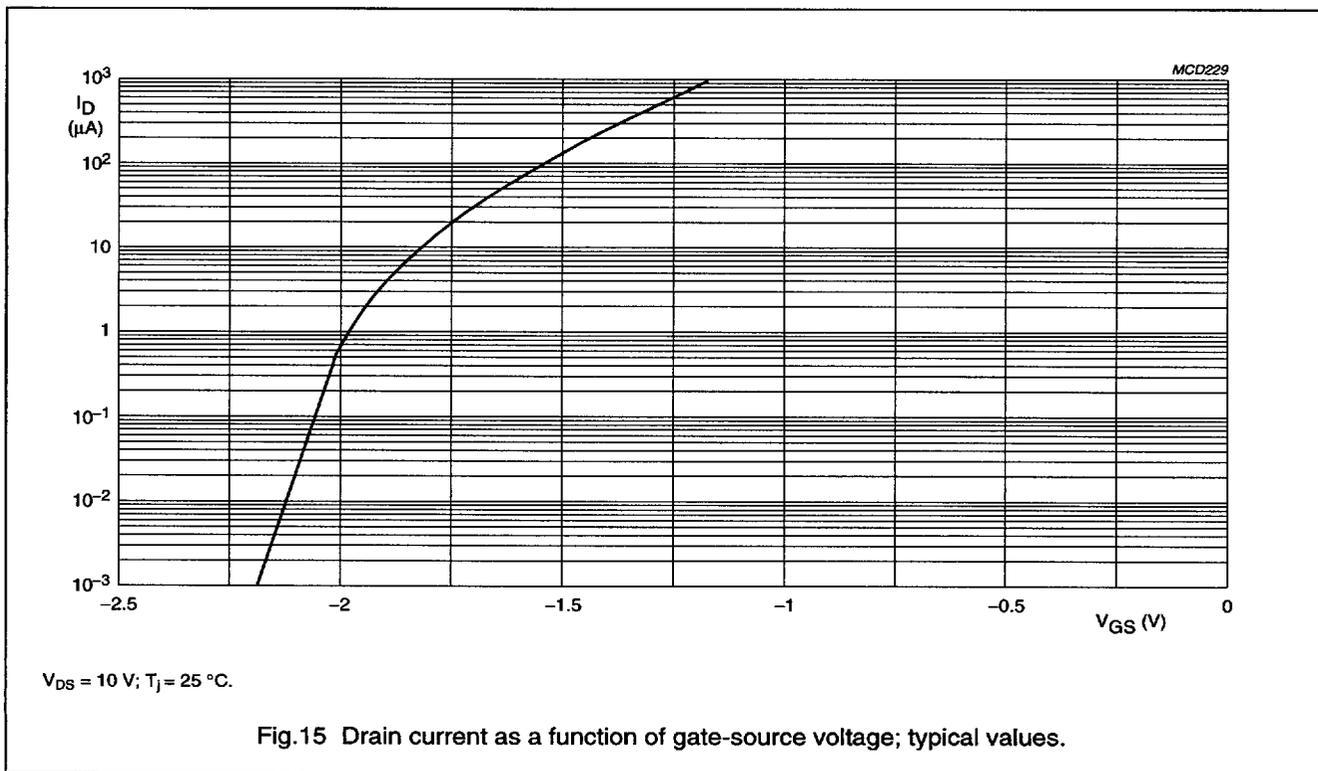
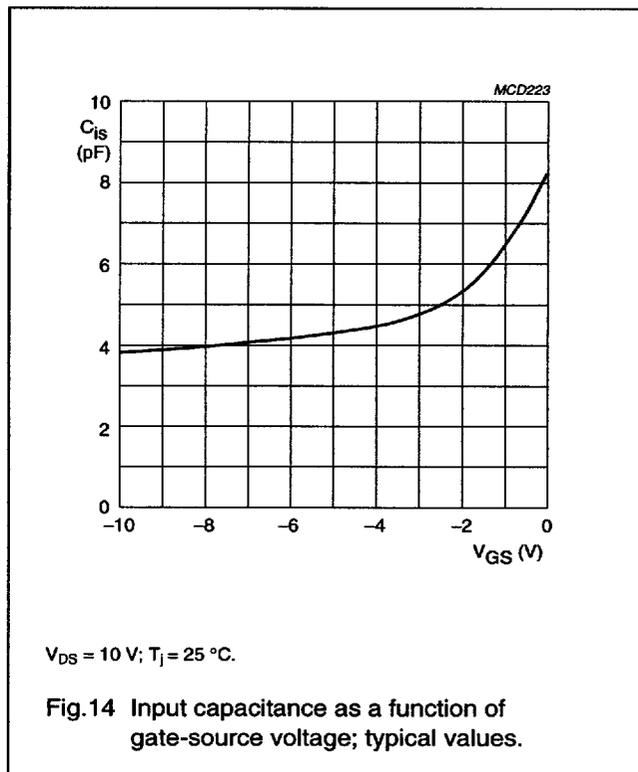
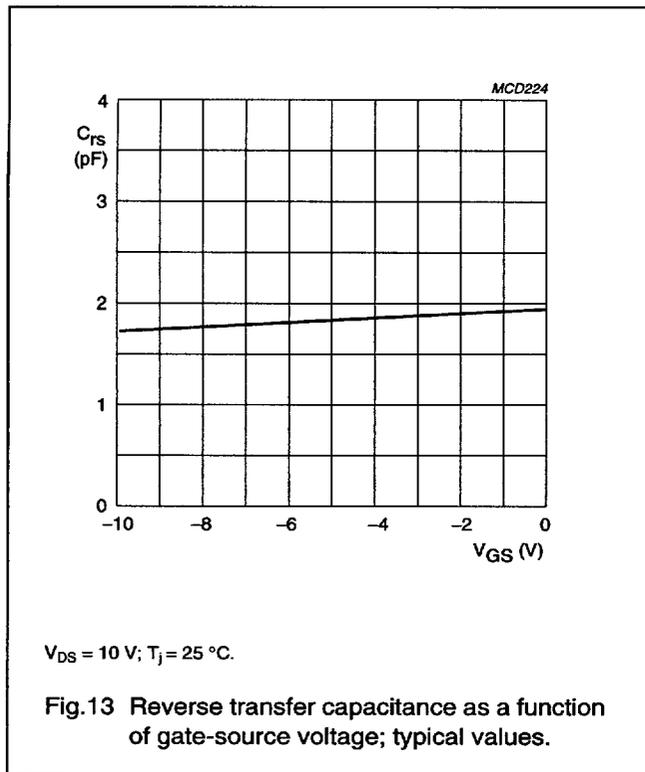
N-channel silicon field-effect transistors

PMBFJ308; PMBFJ309;  
PMBFJ310



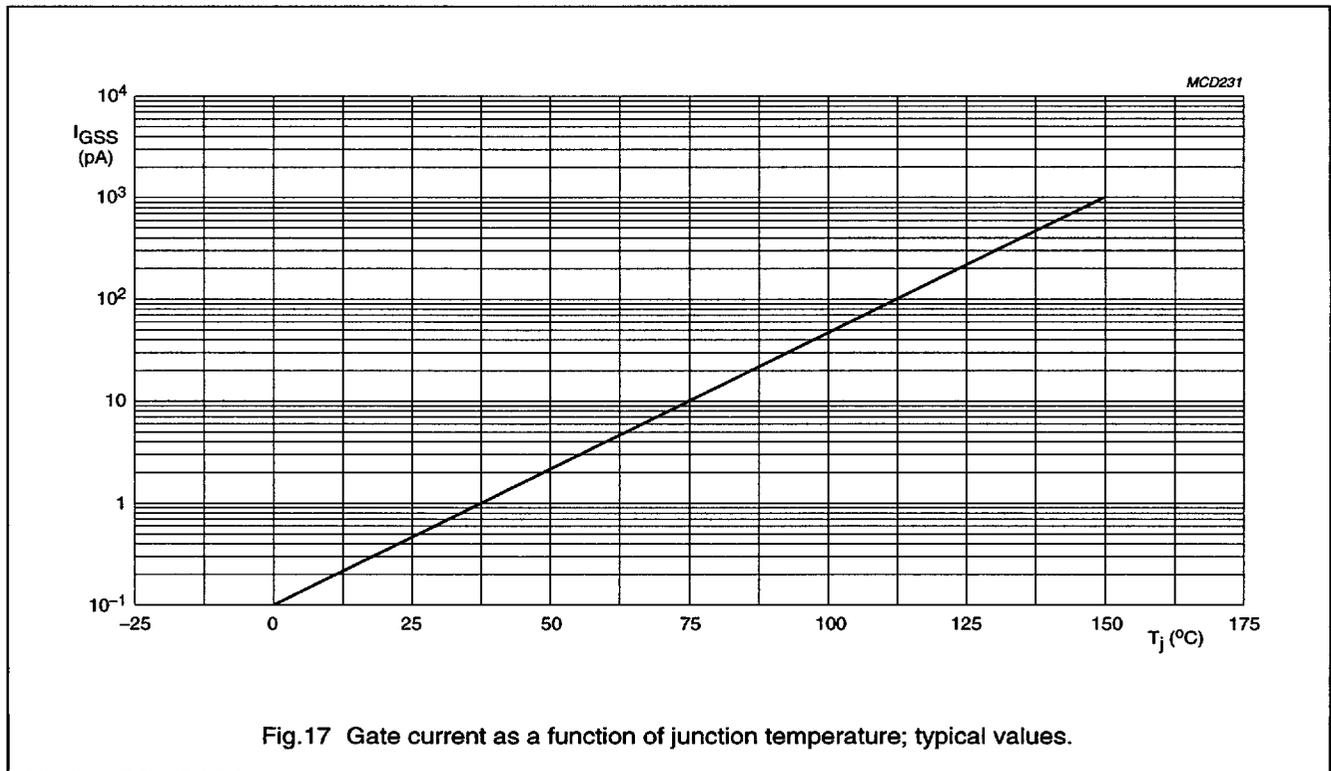
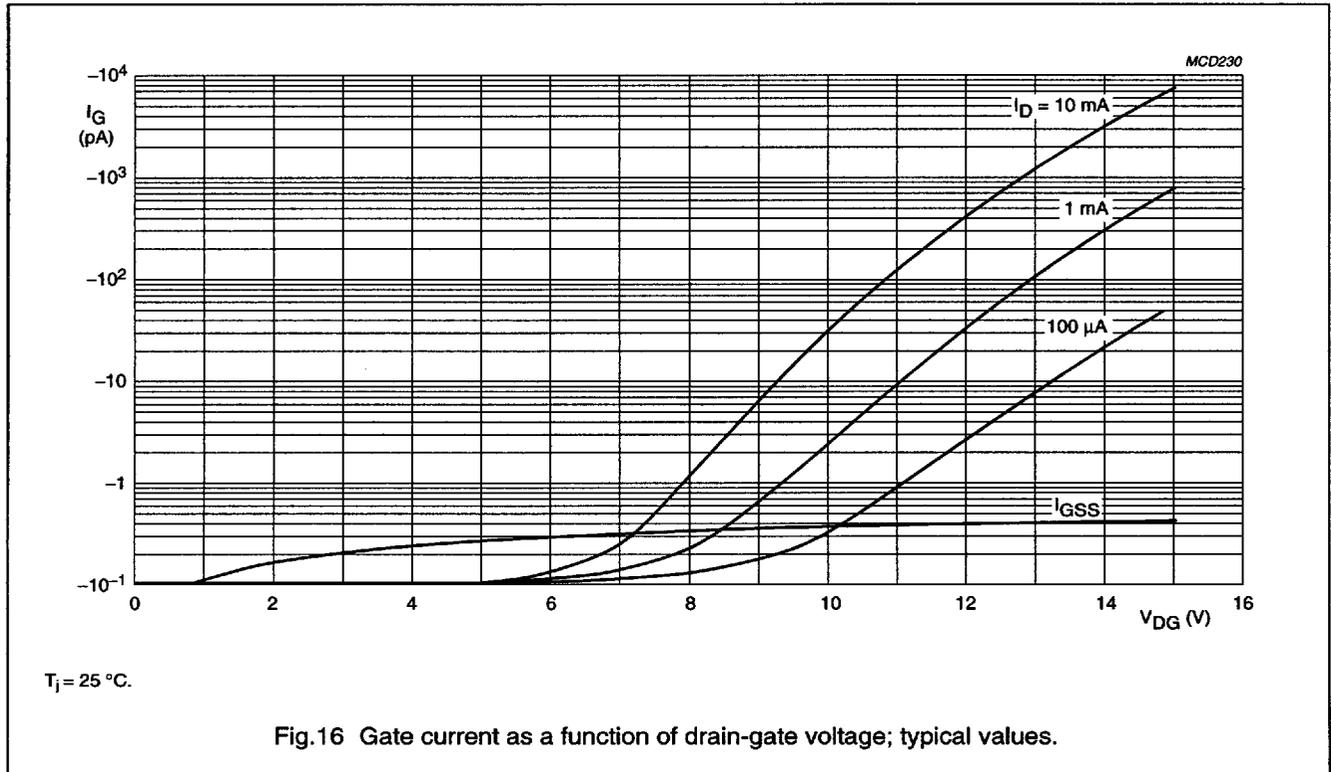
N-channel silicon field-effect transistors

PMBFJ308; PMBFJ309;  
PMBFJ310



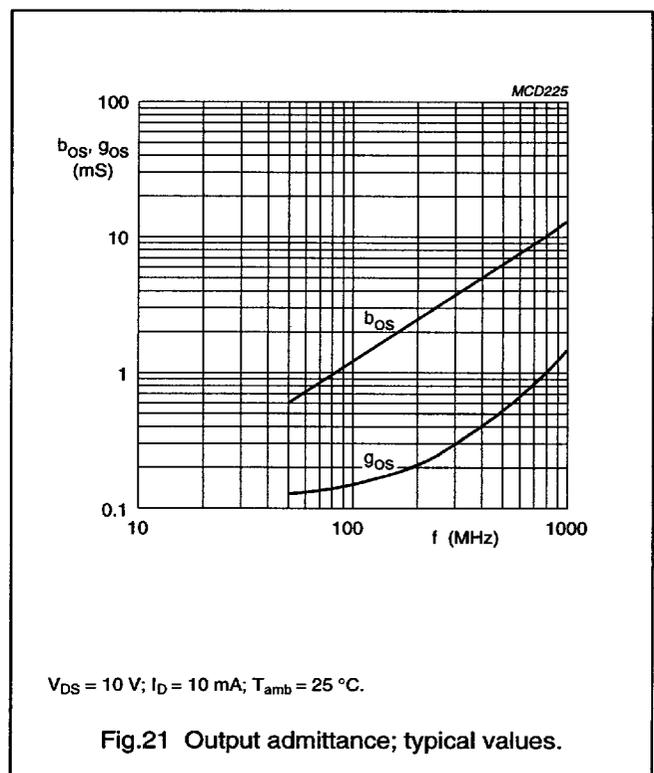
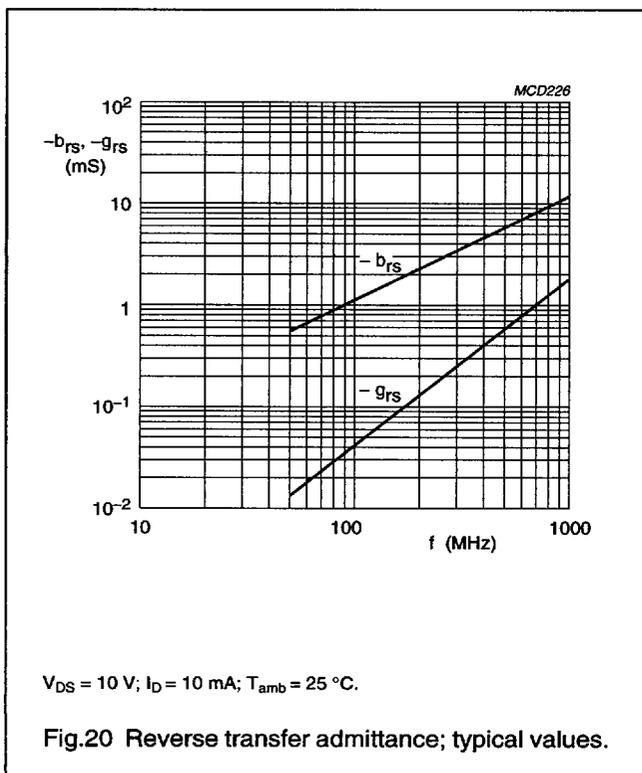
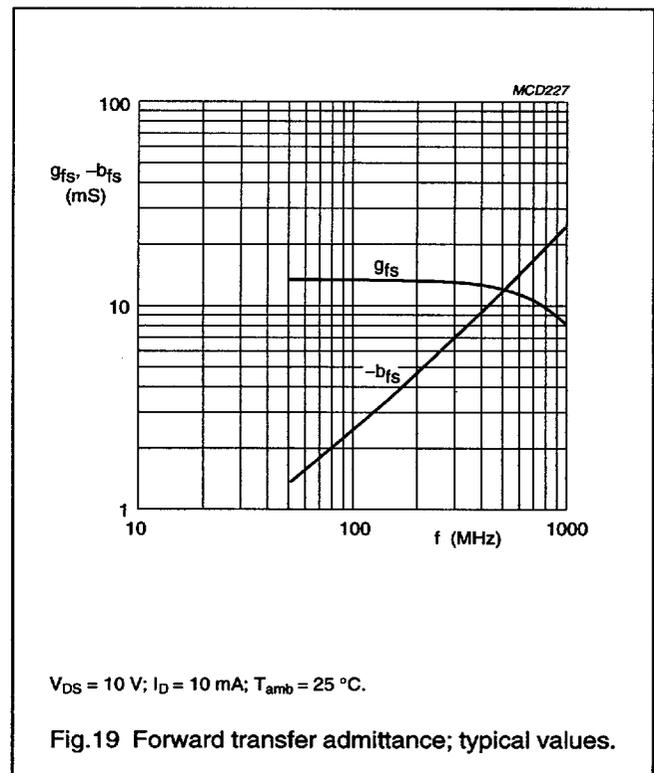
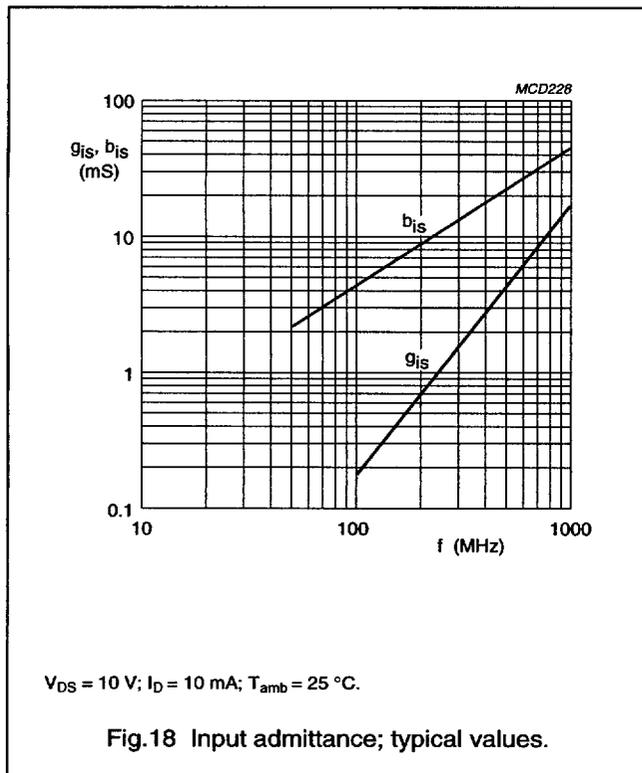
N-channel silicon field-effect transistors

PMBFJ308; PMBFJ309;  
PMBFJ310



N-channel silicon field-effect transistors

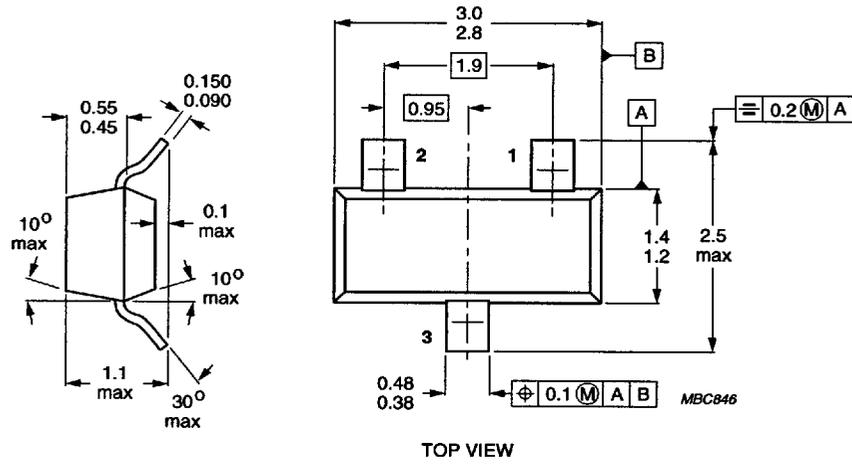
PMBFJ308; PMBFJ309;  
PMBFJ310



# N-channel silicon field-effect transistors

PMBFJ308; PMBFJ309;  
PMBFJ310

## PACKAGE OUTLINE



Dimensions in mm.

Fig.22 SOT 23.